

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TAKEI ET AL.	
		Examiner Ronald Abelson	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0133412 A1	07-2003	Iyer et al.	370/235
*	B	US-2003/0065711	04-2003	Acharya et al.	709/203
	C	US-			
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	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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